

<b>Notice of References Cited</b>	Application/Control No. 09/364,308	Applicant(s)/Patent Under Reexamination PHAN ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,095,480	03-1992	Fenner, Peter R.	370/238
	B	US-5,258,983	11-1993	Lane et al.	370/477
	C	US-5,295,183	03-1994	Langlois et al.	379/112.04
	D	US-5,638,363	06-1997	Gittins et al.	370/358
	E	US-5,894,588	04-1999	Kawashima et al.	710/68
	F	US-5,930,348	07-1999	Regnier et al.	379/221.01
	G	US-6,111,870	08-2000	Kurtz, Scott David	370/344
	H	US-6,226,304	05-2001	Ravishankar et al.	370/527
	I	US-6,330,231	12-2001	Bi, Depeng	370/328
	J	US-6,483,835	11-2002	Tanigawa et al.	370/395.21
	K	US-5,689,641	11-1997	Ludwig et al.	709/241
	L	US-6,359,902	03-2002	Putzolu, David M.	370/466
	M	US-6,122,283	09-2000	Lee	370/408

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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